

**MP7541** 

Multiplying 12-Bit
Digital-to-Analog Converter

### **FEATURES**

- Full Four Quadrant Multiplication
- 12-Bit Linearity
- Guaranteed Monotonic; All Grades; All Temperatures.
- TTL/CMOS Compatible
- Stable, More Accurate Decoded Architecture
  - 2.0 ppm/°C Typ. Gain Error Tempco
  - 0.2 ppm/°C Max. Linearity Tempco
  - Lowest Sensitivity to Output Amplifier Offset
- Latch-Up Free
- PDIP, CDIP, SOIC Packages Available
- Use MP7541B for New Designs

### **APPLICATIONS**

- Industrial Automation
- Automatic Test Equipment
- Disk Drive Servo Systems
- Digital/Synchro Conversion
- Programmable Gain Amplifiers
- Ratiometric A/D Conversion
- Function Generation
- Digitally Controlled Filters

# **GENERAL DESCRIPTION**

The MP7541 is a 12-Bit Digital-to-Analog Converter which is manufactured using Micro Power Systems patented advanced thin film resistor and double metal CMOS process. The MP7541 incorporates a bit decoding technique yielding lower glitch, higher speed and excellent accuracy over temperature and time. The MP7541's outstanding features are:

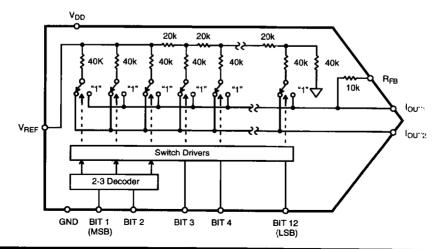
Stability: Both Integral-Non-Linearity and Differential-Non-Linearity are rated at 0.2 ppm/°C maximum. Monotonicity is

guaranteed over the entire temperature rang 3. Gain Temperature Coefficient (TCGE) is 2.0 ppm/°C typical.

Lower Sensitivity to Output Amplifier Ofset: Multiplying DACs provide an output current into a virtual ground of the output op amp. Additional linearity error caused by the op amp is reduced by a factor of 2 in the MP7541 versus conventional R-2R DACs.

Specified for operation over the commercial industrial (–40 to +85°C) and military (–55 to +125°C) temperature ranges, the MP7541 is available in Plastic (PDIP) and Ceranic (CDIP) dual-in-line and Surface Mount (SOIC) packages.

### SIMPLIFIED BLOCK DIAGRAM

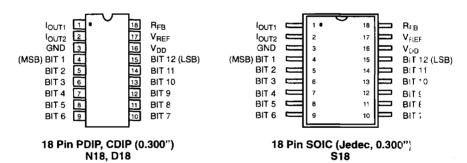




# **ORDERING INFORMATION**

Package Type	Temperature Range	Part No.	INL (LSB)	DNL (LSB)	Gain Error (% FSR)
Plastic Dip	-40 to +85°C	MP7541JN	±1	±1	±0.4
Plastic Dip	-40 to +85°C	MP7541KN	±1/2	±1	±0.4
SOIC	-40 to +85°C	MP7541JS	<u>±</u> 1	±1	±0.4
SOIC	-40 to +85°C	MP7541KS	±1/2	±1	±0.4
Ceramic Dip	-40 to +85°C	MP7541AD	±1	±1	±0.4
Ceramic Dip	-40 to +85°C	MP7541BD	±1/2	±1	±0.4
Ceramic Dip	-55 to +125°C	MP7541SD	±1	±1	±0.4
Ceramic Dip	-55 to +125°C	MP7541SD/883	±1_	±1	±0.4
Ceramic Dip	-55 to +125°C	MP7541TD	±1/2	±1	±0.4
Ceramic Dip	-55 to +125°C	MP7541TD/883	±1/2	±1	±0.4

# **PIN CONFIGURATIONS**



N18, D18

**PIN OUT DEFINITIONS** 

PIN NO.	NAME	DESCRIPTION	
1	l <sub>OUT1</sub>	Current Output 1	
2	I <sub>OUT2</sub>	Current Output 2	
3	GND	Ground	
4	BIT1	Data Input Bit 1 (MSB)	
5	BIT 2	Data Input Bit 2	
6	BIT 3	Data Input Bit 3	
7	BIT 4	Data Input Bit 4	
8	BIT 5	Data Input Bit 5	
9	BIT 6	Data Input Bit 6	

PIN NO.	NAME	DESCRIPTION	
10	BIT 7	Data Input Bit 7	
11	BIT 8	Data Input Bit 3	
12	BIT 9	Data Input Bit 9	
13	BIT 10	Data Input Bit 10	
14	BIT 11	Data Input Bit 11	
15	BIT 12	Data Input Bit 12 (LSB)	
16	V <sub>DD</sub>	Positive Power Supply	
17	V <sub>REF</sub>	Reference Input vo tage	
18	R <sub>FB</sub>	Internal Feedback Resistor	



# **ELECTRICAL CHARACTERISTICS**

 $(V_{DD} = + 15 \text{ V}, V_{REF} = +10 \text{ V} \text{ unless otherwise noted})$ 

			25°C		Tmin to			Took Consider to Construct
Parameter	Symbol	Min	Тур	Гур Мах	Min	Max	Units	Test Conditions/Comments
STATIC PERFORMANCE (1)								FSR = Full Scale Hange
Resolution (All Grades)	N	12			12		Bits	
Integral Non-Linearity	INL						LSB	Best Fit Straight Line Spec.
(Relative Accuracy) J, A, S				±1		±1		(Max INL - Min INL) / 2
K, B, T				±1/2		±1/2		
Differential Non-Linearity	DNL						LSB	All grades monotonic over full
J, A, S K, B, T				±1 ±1		±1 ±1		temperature range
				Ι.		±0.2	ppm/°C	
Non-Linearity Tempco (2)	GE			±0.4		+0.4	% FSR	Using Internal R <sub>FB</sub>
Gain Error				±0.4		_		•
Gain Temperature Coefficient (2)	TC <sub>GE</sub>					<u>+</u> 2	ppm/°C	ΔGain/ΔTemperature
Power Supply Rejection Ratio	PSRR			±100		±200	ppm/%	∆Gain/ΔV <sub>DD</sub>   Δ\′ <sub>DL</sub> ≔ ± 5%
Output Leakage Current	Ιουτ			±50		±200	nA	
DYNAMIC PERFORMANCE (2)								R <sub>L</sub> =100Ω, C <sub>L</sub> ≔13ρF
Current Settling Time	ts		0.5	1			μs	Full Scale Change to 1/2 LSB V <sub>BEE</sub> = 10kHz, 20 Vp-p. sineway
AC Feedthrough at I <sub>OUT1</sub>	F⊤			1			mV p-p	VREF = TUKHZ, 20 "P-p. Silleway
REFERENCE INPUT								
Input Resistance	R <sub>IN</sub>	5		20	5	20	kΩ	
DIGITAL INPUTS (3)								
Logical "1" Voltage	VIH	2.4			2.4		V	
Logical "0" Voltage Input Leakage Current	V <sub>IL</sub> I <sub>LKG</sub>			0.8 ±1		0.8 ±1	V μ <b>A</b>	
Input Capacitance (2)	1	1		_		_		
Data	C <sub>IN</sub>			8	<u> </u>		pF	
ANALOG OUTPUTS								
Output Capacitance (2)	<b>C</b>			52			pF	DAC Inputs all 1 s
	C <sub>OUT1</sub>			26			pF	DAC Inputs all 0 s
	C <sub>OUT2</sub>			13			pF pF	DAC Inputs all 1 s DAC Inputs all 0 s
DOWED CHOOL V (4)	C <sub>OUT2</sub>	├		45	<del> </del> -		P' -	5,10 inputs ail 08
POWER SUPPLY (4)	l			46	۱ ,,	40	,,	
Functional Voltage Range (2) Supply Current	V <sub>DD</sub>	4.5		16 2	4.5	16 2	mA	All digital inputs ∈ € ∀ or all = V

### NOTES:

- (1) Full Scale Range (FSR) is 10V for unipolar mode.
- (2) Guaranteed but not production tested.
- Digital input levels should not go below ground or exceed the positive supply voltage, otherwise damage may occur.
- (4) Specified values guarantee functionality. Refer to other parameters for accuracy.

Specifications are subject to change without notice

# **MP7541**



# ABSOLUTE MAXIMUM RATINGS (1, 2) (TA = +25°C unless otherwise noted)

V <sub>DD</sub> to GND+17 V Digital Input Voltage to GND GND -0.5 to V <sub>DD</sub> +0.5 V	Storage Temperature(.5°C to +150°C Lead Temperature (Soldering, 10 seconds) +300°C
l <sub>OUT1</sub> , l <sub>OUT2</sub> to GND GND -0.5 to V <sub>DD</sub> +0.5 V V <sub>REF</sub> to GND ±25 V V <sub>RFB</sub> to GND ±25 V	Package Power Dissipation Rating to 75°C CDIP, PDIP, SOIC

### NOTES:

(1) Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the clevice. This is a stress rating only and functional operation at or above this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

Any input pin which can see a value outside the absolute maximum ratings should be protected by Schottley diode clamps (HP5082-2835) from input pin to the supplies. All inputs have protection diodes which will protect the device from short transients outside the supplies of less than 20mA for less than 100µs.

**APPLICATION NOTES** Refer to Section 8 for Applications Information